

AON2803

20V Dual P-Channel MOSFET

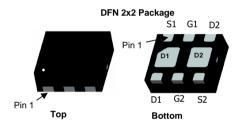
General Description

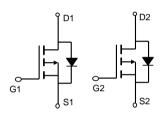
The AON2803 uses advanced trench technology to provide excellent $R_{\rm DS(ON)},$ low gate charge and operation with gate voltage as low as 1.8V. This device is suitable for use as a load switch or in PWM applications.

Product Summary

 $\begin{array}{lll} V_{DS} & -20V \\ I_{D} \; (at \; V_{GS} \!\!=\!\! -4.5V) & -3.8A \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\!\! -4.5V) & <70m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\!\! -2.5V) & <90m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\!\! -1.8V) & <115m\Omega \end{array}$







Absolute Maximum Ratings T _A =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		V _{DS}	-20	V				
Gate-Source Voltage		V_{GS}	±8	V				
Continuous Drain Current	T _A =25°C		-3.8					
	T _A =70°C	I _D	-3	Α				
Pulsed Drain Current ^C		I _{DM}	-20					
	T _A =25°C	Ь	1.5	W				
Power Dissipation ^A	T _A =70°C	P_{D}	0.95	VV				
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C				

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	35	45	°C/W			
Maximum Junction-to-Ambient A	Steady-State	$R_{\theta JA}$	65	85	°C/W			
Maximum Junction-to-Ambient ^B	t ≤ 10s	$R_{ heta JA}$	120	155	°C/W			
Maximum Junction-to-Ambient ^B	Steady-State	IN _θ JA	175	235	°C/W			



Electrical Characteristics (T₁=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-20V, V _{GS} =0V			-1	μА			
		T _J =55°0			-5				
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±8V			±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=-250\mu A$	-0.4	-0.6	-1	V			
I _{D(ON)}	On state drain current	V_{GS} =-4.5V, V_{DS} =-5V	-20			Α			
R _{DS(ON)} Static Drain-Source	Chatia Drain Cauras On Desistance	V _{GS} =-4.5V, I _D =-3.8A		58	70	mΩ			
		T _J =125°0		78	94	11122			
	Static Dialii-Source On-Resistance	V_{GS} =-2.5V, I_D =-3A		70	90	$m\Omega$			
		V_{GS} =-1.8V, I_D =-2A		85	115	mΩ			
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-3.8A		15		S			
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V		-0.66	-1	V			
Is	Maximum Body-Diode Continuous Curre			-2	Α				
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance			560		pF			
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =-10V, f=1MHz		80		pF			
C_{rss}	Reverse Transfer Capacitance			70		pF			
R_g	Gate resistance	$V_{GS}=0V$, $V_{DS}=0V$, $f=1MHz$		15	30	Ω			
SWITCHI	NG PARAMETERS								
Q_g	Total Gate Charge			8.5	12	nC			
Q_{gs}	Gate Source Charge	V_{GS} =-4.5V, V_{DS} =-10V, I_{D} =-3.8A		1.2		nC			
Q_{gd}	Gate Drain Charge			2.1		nC			
t _{D(on)}	Turn-On DelayTime			7.2		ns			
t _r	Turn-On Rise Time	V_{GS} =-4.5V, V_{DS} =-10V, R_L =2.6 Ω ,		36		ns			
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		53		ns			
t _f	Turn-Off Fall Time	7		56		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =-3.8A, dI/dt=100A/μs		37		ns			
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =-3.8A, dI/dt=100A/μs		27		nC			

A: The value of R $_{0JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25 $^\circ$ C. The Power dissipation P_{DSM} is based on R $_{\theta JA}$ and the maximum allowed junction temperature of 150 $^{\circ}$ C.

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B. The value of R $_{0,JA}$ is measured with the device mounted on a minimum pad board. Copper, in a still air environment with T $_A$ =25° C. The Power dissipation P_{DSM} is based on R $_{\theta JA}$ and the maximum allowed junction temperature of 150 $^{\circ}$ C.

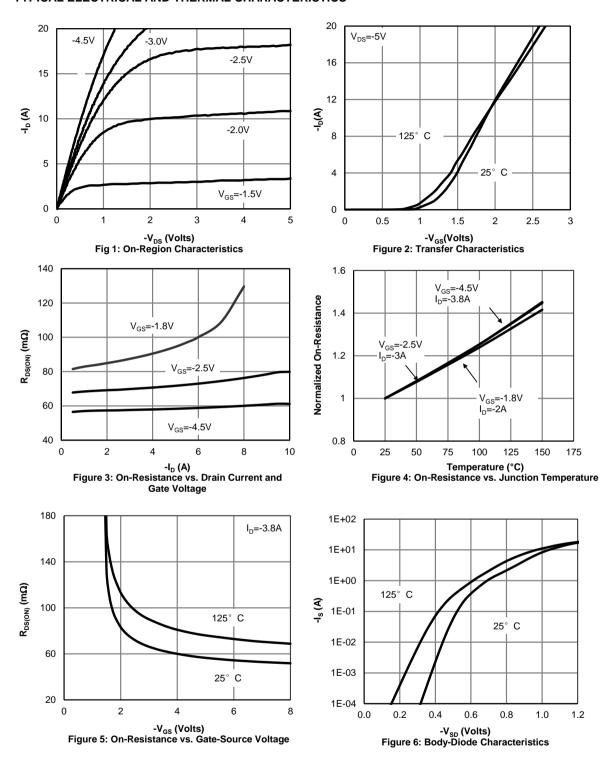
C. The R $_{\theta JA}$ is the sum of the thermal impedance from junction to case R $_{\theta JC}$ and case to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in ² FR-4 board with 2oz. Copper, in a still air environment with T _A=25° C. The SOA curve provides a single pulse rating.

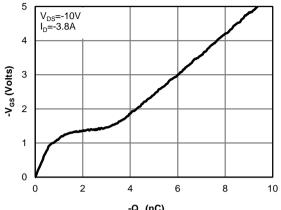


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

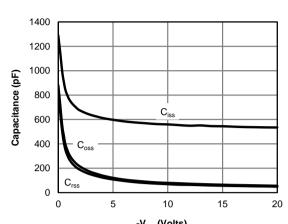




TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 $-Q_g$ (nC) Figure 7: Gate-Charge Characteristics



-V_{DS} (Volts)
Figure 8: Capacitance Characteristics

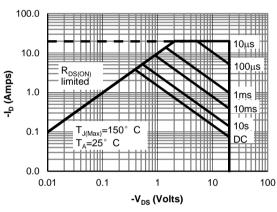
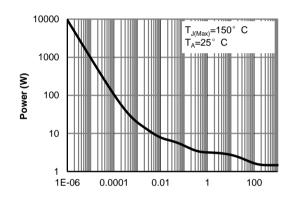


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)



Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toAmbient (Note E)

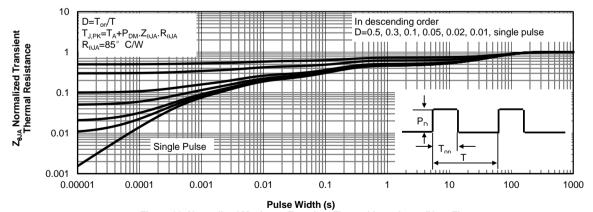
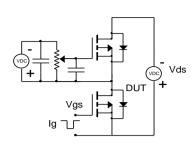
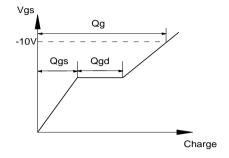


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)

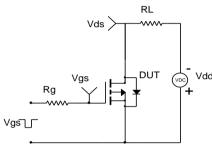


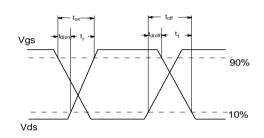
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

